

December 2009

# FDMS7700S

# Dual N-Channel PowerTrench<sup>®</sup> MOSFET N-Channel: 30 V, 30 A, 7.5 m $\Omega$ N-Channel: 30 V, 40 A, 2.4 m $\Omega$

### Features

### Q1: N-Channel

- Max  $r_{DS(on)}$  = 7.5 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 12 A
- Max  $r_{DS(on)}$  = 12 m $\Omega$  at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 10 A

### Q2: N-Channel

- Max  $r_{DS(on)}$  = 2.4 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 20 A
- Max  $r_{DS(on)}$  = 2.9 m $\Omega$  at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 18 A
- RoHS Compliant

# **General Description**

This device includes two specialized N-Channel MOSFETs in a dual MLP package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFET (Q2) have been designed to provide optimal power efficiency.

### Applications

- Computing
- Communications
- General Purpose Point of Load
- Notebook VCORE



# MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V <sub>DS</sub>	Drain to Source Voltage		30	30	V
V <sub>GS</sub>	Gate to Source Voltage	(Note 3)	±20	±20	V
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C	30	40	
	-Continuous (Silicon limited)	T <sub>C</sub> = 25 °C	50	120	A
D	-Continuous	T <sub>A</sub> = 25 °C	12 <sup>1a</sup>	22 <sup>1b</sup>	~
	-Pulsed		40	60	
D	Power Dissipation for Single Operation	T <sub>A</sub> = 25 °C	2.2 <sup>1a</sup>	2.5 <sup>1b</sup>	W
P <sub>D</sub>		T <sub>A</sub> = 25 °C	1.0 <sup>1c</sup>	1.0 <sup>1d</sup>	vv
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to	+150	°C

## **Thermal Characteristics**

$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	57 <sup>1a</sup>	50 <sup>1b</sup>	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	125 <sup>1c</sup>	120 <sup>1d</sup>	°C/W
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	3.5	2	

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7700S	FDMS7700S	Power 56	13 "	12 mm	3000 units

FDMS7700S Dual N-Channel PowerTrench<sup>®</sup> MOSFET

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units	
Off Chara	octeristics							
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$ $I_D = 1 \ m A, \ V_{GS} = 0 \ V$	Q1 Q2	30 30			V	
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 1 \ m$ A, referenced to 25 °C	Q1 Q2		15 14		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V},  V_{GS} = 0 \text{ V}$	Q1 Q2			1 500	μΑ μΑ	
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V	Q1 Q2			100 100	nA nA	
On Chara	cteristics							
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250 \ \mu A$ $V_{GS} = V_{DS}$ , $I_D = 1 \ m A$	Q1 Q2	1 1	1.8 1.5	3 3	V	
$rac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 1 \ m$ A, referenced to 25 °C	Q1 Q2		-6 -4		mV/°C	
-	Drain to Source On Registeres		Q1		6.0 8.5 8.3	7.5 12 12		
r <sub>DS(on)</sub>	Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$ $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 18 \text{ A}$ $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 125 \text{ °C}$	Q2		1.9 2.2 2.1	2.4 2.9 3.4	9	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 V, I_D = 12 A$ $V_{DS} = 5 V, I_D = 20 A$	Q1 Q2		63 160		S	

### **Dynamic Characteristics**

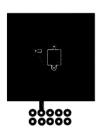
C <sub>iss</sub>	Input Capacitance	Q1: V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHZ	Q1 Q2	1315 7240	1750 9630	pF
C <sub>oss</sub>	Output Capacitance	Q2:	Q1 Q2	445 2690	600 3580	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHZ	Q1 Q2	45 185	70 280	pF
Rg	Gate Resistance		Q1 Q2	0.9 0.8		Ω

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time	_		Q1 Q2	8.6 21	18 34	ns
t <sub>r</sub>	Rise Time	Q1: V <sub>DD</sub> = 15 V, I <sub>D</sub> = 12	$P$ A, $R_{GEN} = 6 \Omega$	Q1 Q2	2.5 9.2	10 18	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	Q2: V <sub>DD</sub> = 15 V, I <sub>D</sub> = 20	A R = 6 0	Q1 Q2	20 58	32 93	ns
t <sub>f</sub>	Fall Time	VDD - 13 V, 10 - 20	7, TGEN - 0 32	Q1 Q2	2.3 6.8	10 14	ns
Qg	Total Gate Charge	$V_{GS} = 0$ V to 10 V	Q1	Q1 Q2	20 105	28 147	nC
Qg	Total Gate Charge	$V_{GS} = 0$ V to 4.5 V	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 12 A	Q1 Q2	9.3 48	13 67	nC
Q <sub>gs</sub>	Gate to Source Gate Charge		Q2 V <sub>DD</sub> = 15 V,	Q1 Q2	4.3 19		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge		$V_{DD} = 13 V,$ $I_{D} = 20 A$	Q1 Q2	2.2 11		nC

Symbol	Parameter	Test Conditions	Туре	e Min	Тур	Max	Units
Drain-Sou	Irce Diode Characteristics				,		
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 12 A$ (Note $V_{GS} = 0 V, I_S = 20 A$ (Note	,		0.8 0.7	1.2 1.2	V
t <sub>rr</sub>	Reverse Recovery Time	Q1 I <sub>F</sub> = 12 A, di/dt = 100 A/μs	Q1 Q2		27 53	43 85	ns
Q <sub>rr</sub>	Reverse Recovery Charge	Q2 I <sub>F</sub> = 20 A, di/dt = 300 A/µs	Q1 Q2		10 100	18 160	nC

Notes: 1: R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



c. 125 °C/W when mounted on a minimum pad of 2 oz copper

a. 57 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



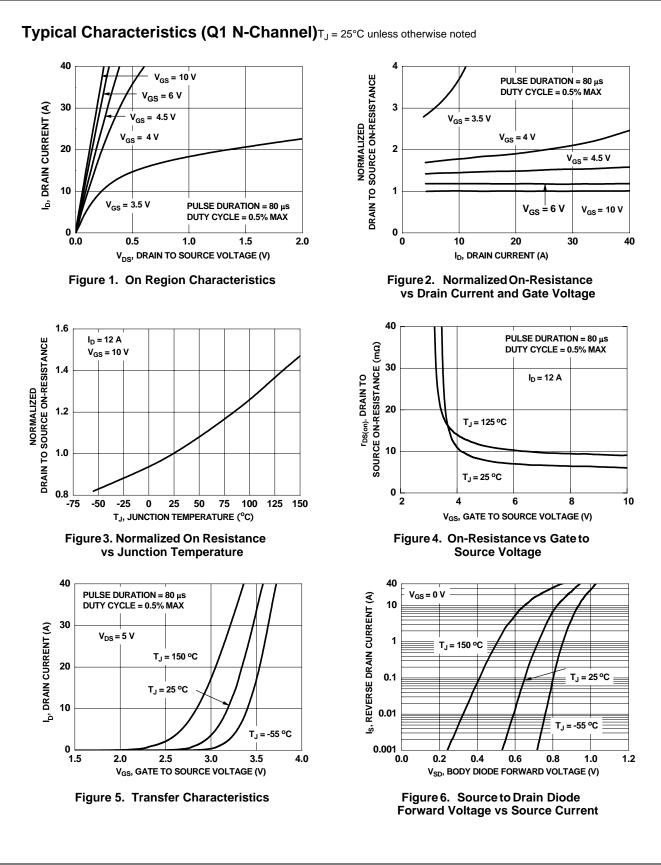
80000

d. 120 °C/W when mounted on a minimum pad of 2 oz copper

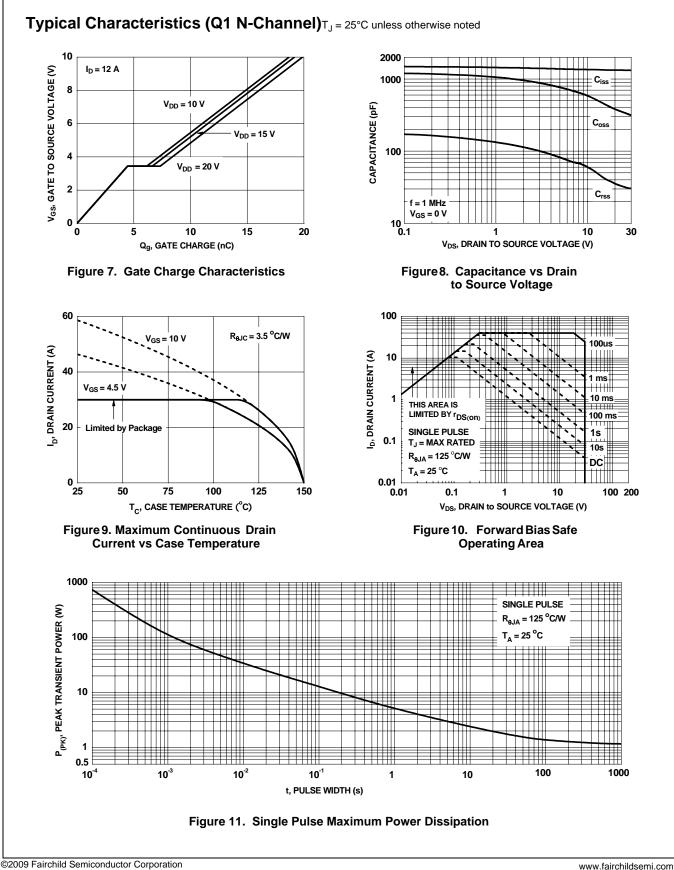
b. 50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

2: Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.

3: As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.

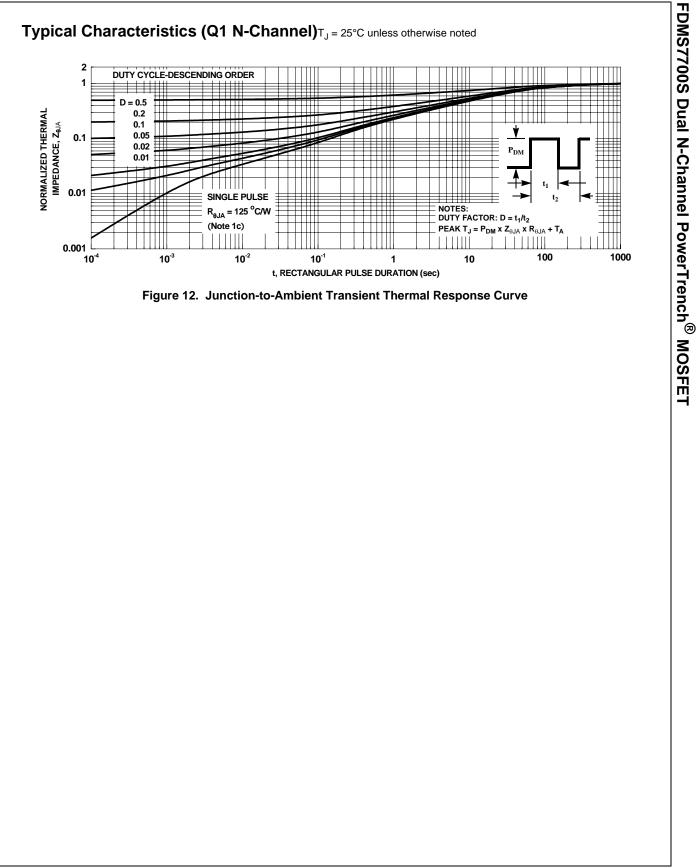


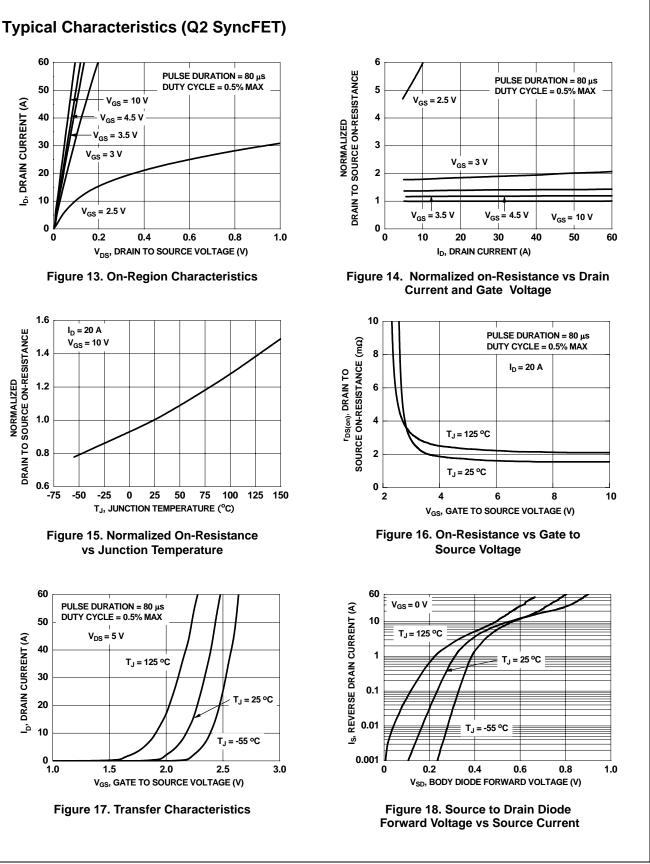
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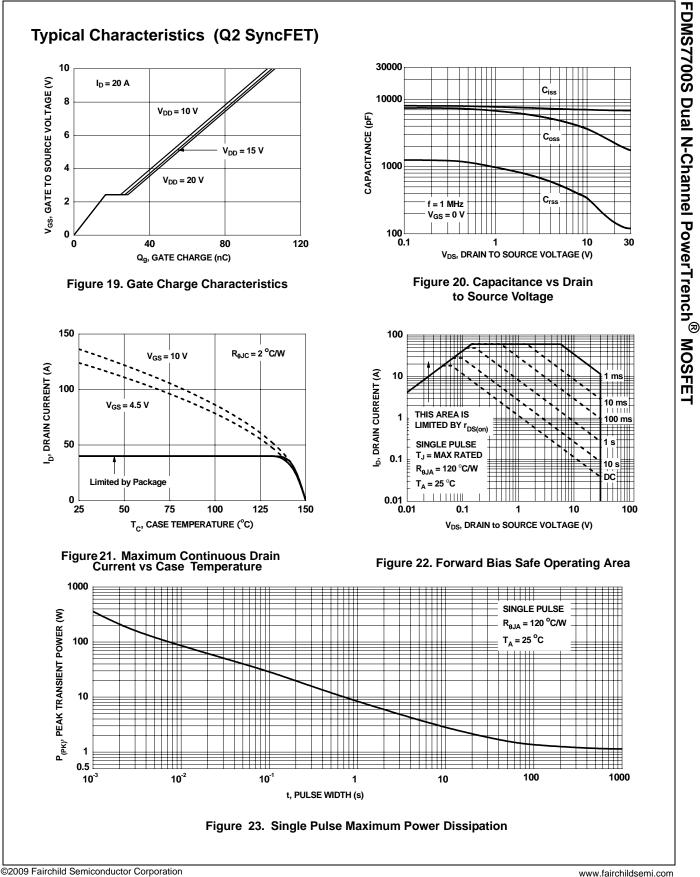




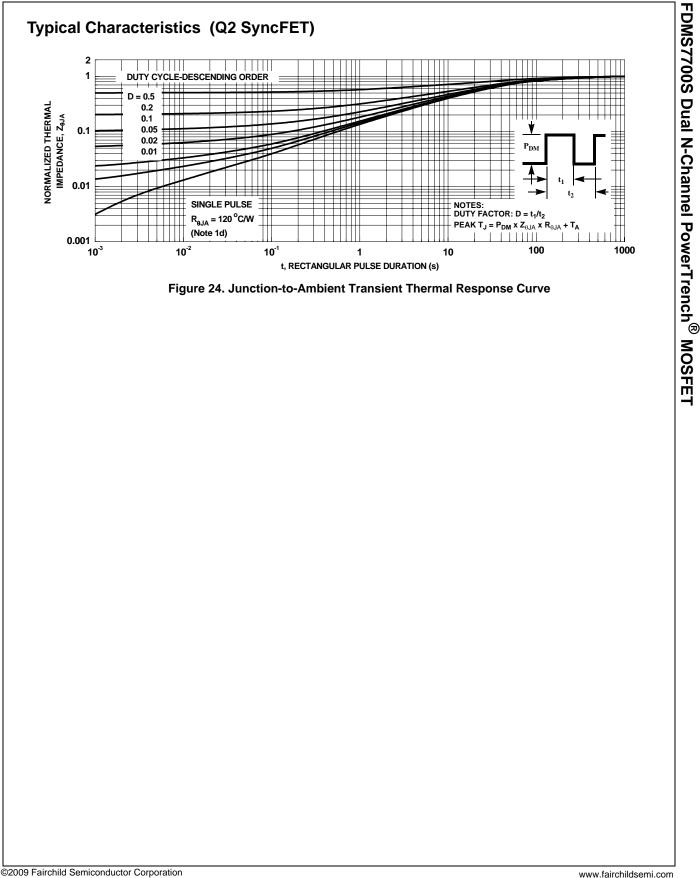
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FDMS7700S Rev.C



FDMS7700S Rev.C

# FDMS7700S Dual N-Channel PowerTrench<sup>®</sup> MOSFET

# Typical Characteristics (continued)

### SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 25 shows the reverse recovery characteristic of the FDMS7700S.

 $\begin{array}{c}
12 \\
9 \\
6 \\
3 \\
0 \\
-3 \\
-6 \\
100 \\
150 \\
150 \\
200 \\
250 \\
300 \\
TIME (ns)
\end{array}$ 

Figure 25. FDMS7700S SyncFET body diode reverse recovery characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

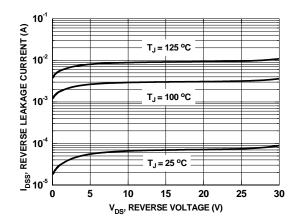
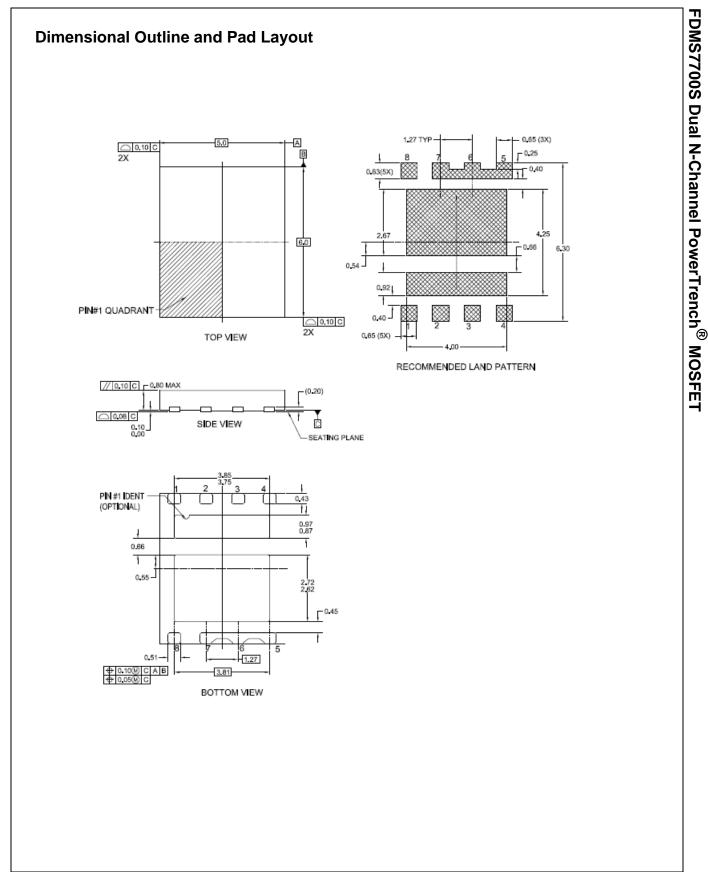


Figure 26. SyncFET body diode reverse leakage versus drain-source voltage



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FastvCore™	(1)	Sync-Lock™	VisualMax™
FETBench™	PDP SPM™	SYSTEM ®*	XS™
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